

D9310A

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re amendment to CRAIG PRATER patent application

Serial No. 08/871,029

Examiner: Daniel Larkin

Filed: June 9, 1997

Art Unit: 2856

For: SCANNING STYLUS ATOMIC FORCE MICROSCOPE
WITH CANTILEVER TRACKING AND OPTICAL
ACCESSAssistant Commissioner of Patents
Washington, D.C. 20231**SUPPLEMENTAL AMENDMENT**

Sir:

Supplementing the Amendment sent on November 13, 2001, and at the request of Examiner Larkin, here are clean copies of claims 71 and 72 as follows:

71. (amended) The microscope of claim 66, wherein said detection device generates a signal which is processed to create a control signal to servo said motion control device, wherein said control signal is further used in conjunction with applied position signals to create a three dimensional map of the sample surface.

AMENDMENT TO D9310A 122101.WPD
FRIDAY, DECEMBER 21, 2001

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